



Docket No.: WEN-019  
(PATENT)

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Patent Application of:  
Naoki ISOGAI

Application No.: Not Yet Assigned

Group Art Unit: N/A

Filed: June 26, 2003

Examiner: Not Yet Assigned

For: REFRACTIVE POWER MEASUREMENT  
APPARATUS

**CLAIM FOR PRIORITY AND SUBMISSION OF DOCUMENTS**

MS Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

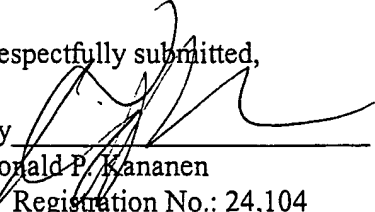
Applicant hereby claims priority under 35 U.S.C. 119 based on the following prior foreign application filed in the following foreign country on the date indicated:

| <u>Country</u> | <u>Application No.</u> | <u>Date</u>   |
|----------------|------------------------|---------------|
| Japan          | JP 2002-190737         | June 28, 2002 |

In support of this claim, a certified copy of the said original foreign application is filed herewith.

Dated: June 26, 2003

Respectfully submitted,

By   
Ronald P. Kananen  
Registration No.: 24,104  
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Attorneys for Applicant

日 本 国 特 許 庁  
JAPAN PATENT OFFICE

別紙添付の書類に記載されている事項は下記の出願書類に記載されている事項と同一であることを証明する。

This is to certify that the annexed is a true copy of the following application as filed with this Office

出 願 年 月 日

Date of Application:

2002年 6月28日

出 願 番 号

Application Number:

特願2002-190737

[ST.10/C]:

[JP2002-190737]

出 願 人

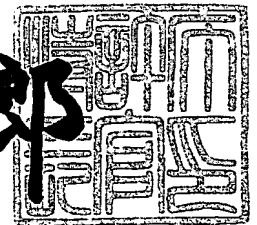
Applicant(s):

株式会社ニデック

2003年 3月24日

特 許 庁 長 官  
Commissioner,  
Japan Patent Office

太田 信一郎



出証番号 出証特2003-3019714